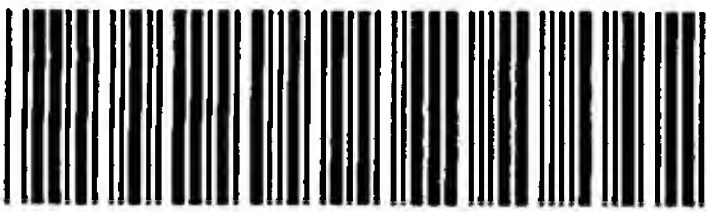


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/581,332	WARNKE, WOLFGANG	
	Examiner	Art Unit	
	Nguyen N. Hanh	2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	233	8/11/2007	HN
310	235	8/11/2007	HN
310	236	8/11/2007	HN
29	596	8/11/2007	HN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR